

Characterisation of SiPM at cryogenic temperatures

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degli Studi
di Ferrara



Overview

Outlook:

- Background
- Setup
- Measurements
- Burst effect
- Results
- Conclusions

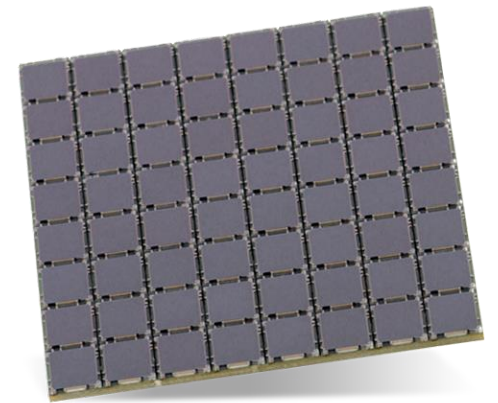
Background

"Photodetectors and sensors for particle identification and new physics searches"

Need best performances from each photodetector in terms of:

- Photodetection efficiency (PDE);
- Gain;
- S/N;
- Dark count rate (DCR);
- Correlated noise;
- Radiation hardness;
- Resilience to stresses;
- Cost;
- Adjustable shape;

⇒ SiPMs could be a solution!



Study and characterize sensors in different conditions of operation

SiPM models for initial tests

HPK 13360-3025CS: 2022

- 3x3mm² area
- 25um pitch
- Glass epoxy

HPK 13360-3025PE: 2022

- 3x3mm² area
- 25um pitch
- Ceramic

HPK 14160-3015PS: 2022

- 3x3mm² area
- 15um pitch
- Surface mount

HPK 13360-3050HS: 2022

- 3x3mm² area
- 50um pitch
- Surface mount

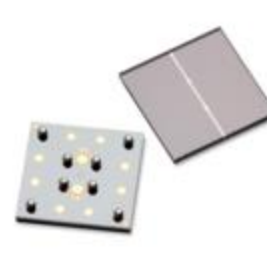
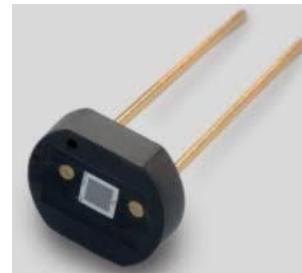
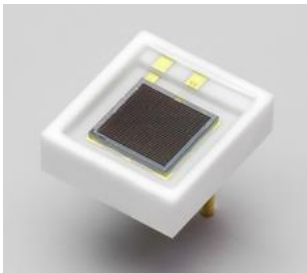
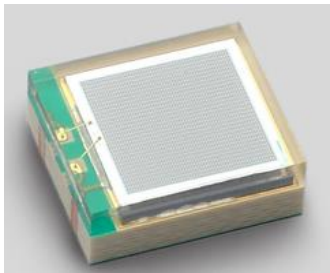
HPK 13360-3050VE: 2022

- 3x3mm² area
- 50um pitch
- Surface mount

HPK 13081-050CS: 2015 (discontinued)

- 1x1mm² area
- 50um pitch

New FBK + Broadcom sensors procurement



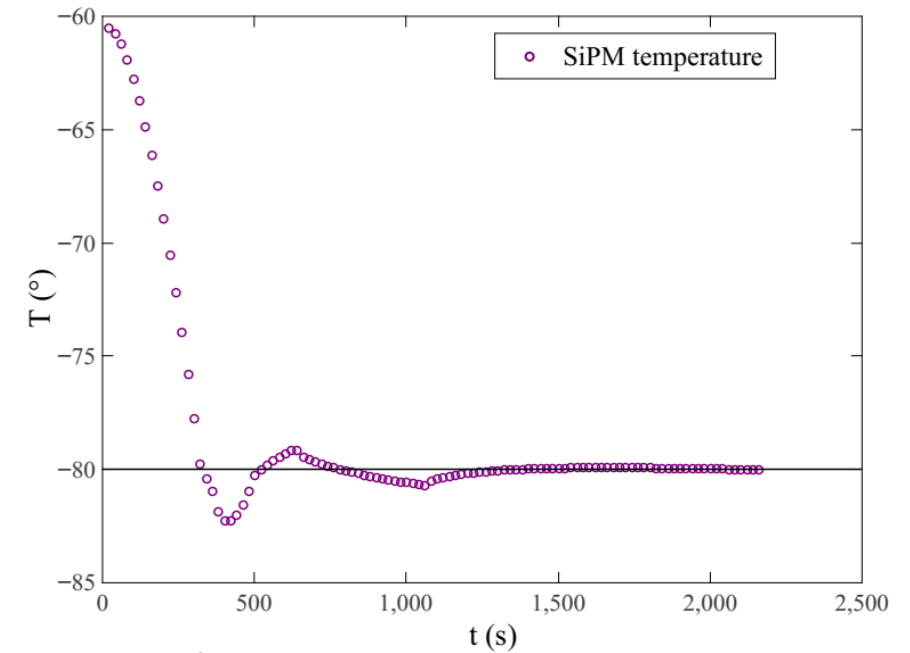
Setup (1)

Multipurpose setup for SiPM characterization in a wide temperature range (from -150° to 25°)



Setup:

- liquid nitrogen cryostat (LN2) 14l;
- source meter unit Keithley SM2450 resolution $<1\text{pA}$, triaxial cables ;
- stabilized power supply Keysight E3630;
- oscilloscope (Tektronix MSO 64) 12bit res., 2.5GHz bandwidth, sampling 25GS/s;
- mechanical linear stage software controlled;
- cold amplifier not designed for fast signals;
- led system at 470nm;
- pulsed UV laser Hamamatsu PLP10 @405nm, 50ps pulse width ;
- fast amplifiers Hamamatsu and Fast 2GHz bandwidth.



Example: $T_{\text{set}}=-80^{\circ}$, $T_{\text{initial}}=-60^{\circ}$



PYTHON
SCRIPT



MECHANICAL
STAGE



PT100
TEMPERATUR
E SENSOR



SIMPLE
FEEDBACK
CONTROL



LN2 VAPOUR

Setup (2)

The setup can perform:

- **IV curve through the source meter unit SM2450**

Quenching resistor R_q ;

Breakdown voltage V_{bd} ;

- **DCR analysis through power supply + amplification + oscilloscope**

Primary DCR;

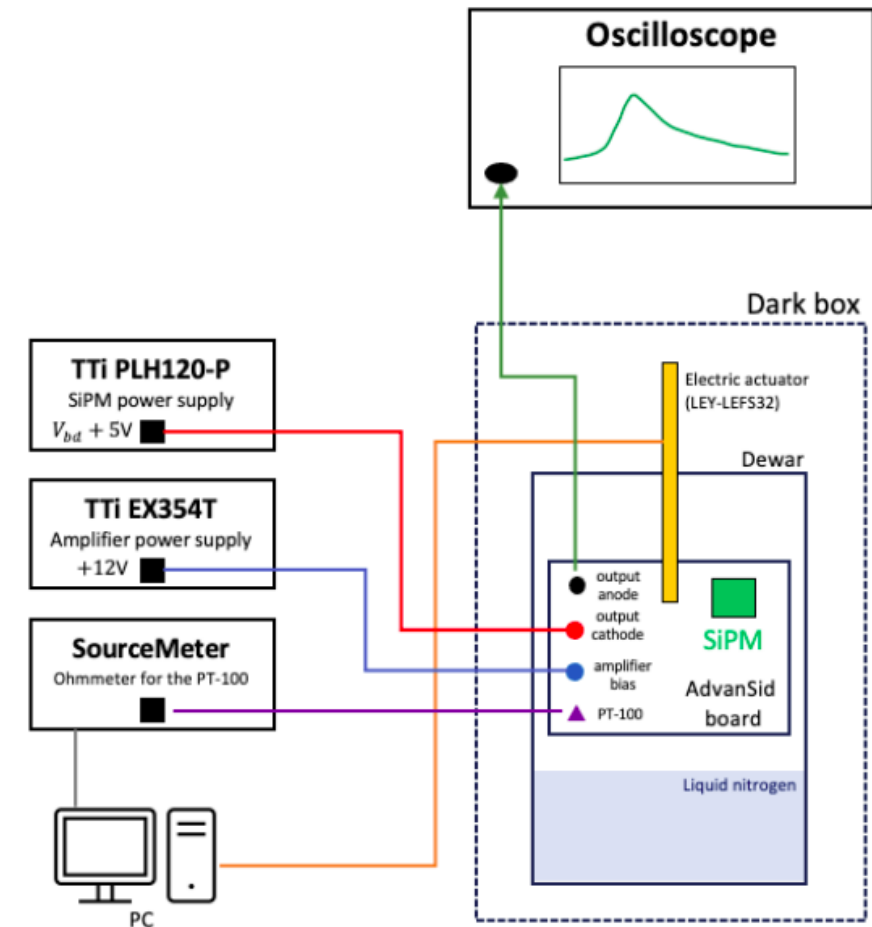
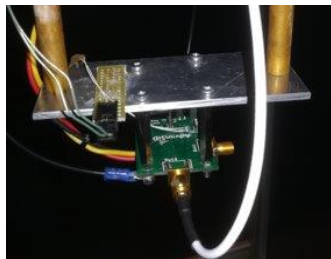
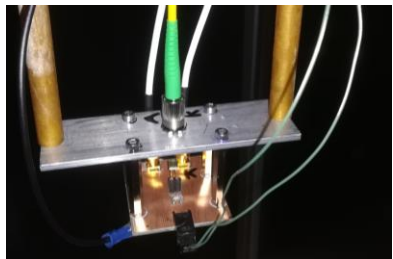
Afterpulses;

Cross-talk;

Burst effect;

- **Temporal study through power supply + amplification + oscilloscope + Laser source**

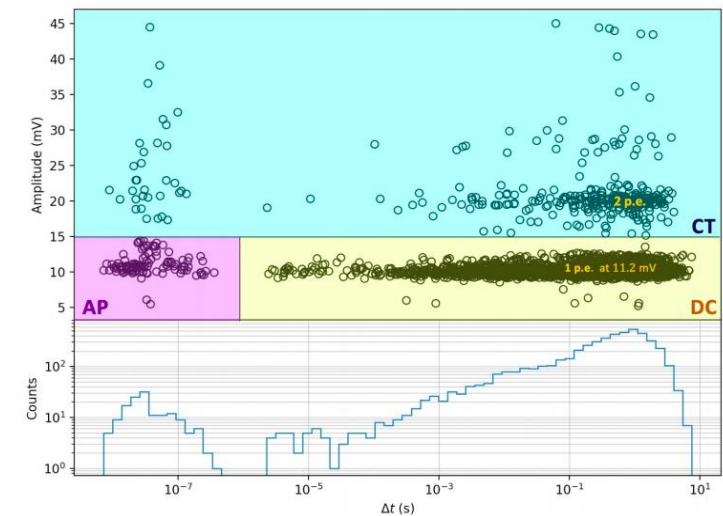
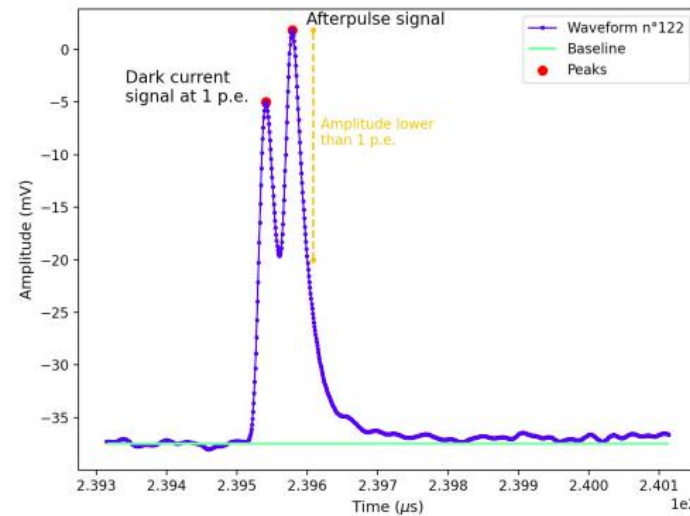
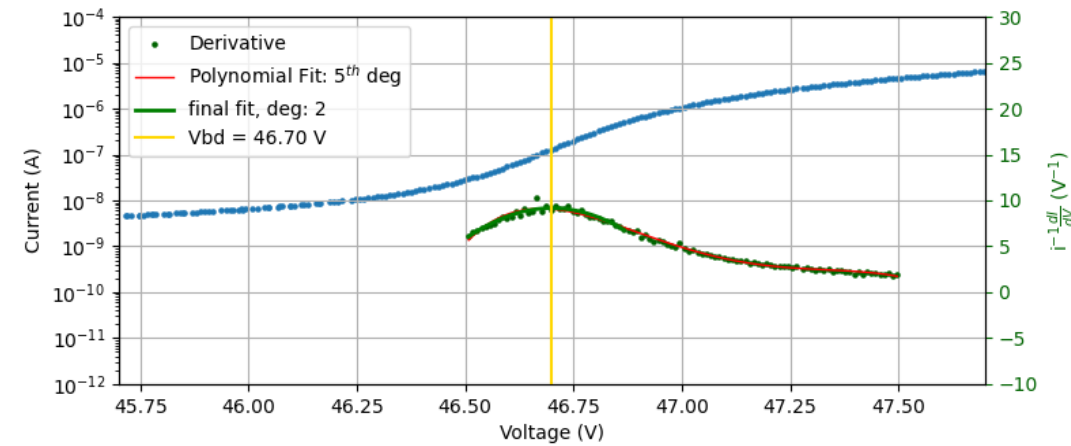
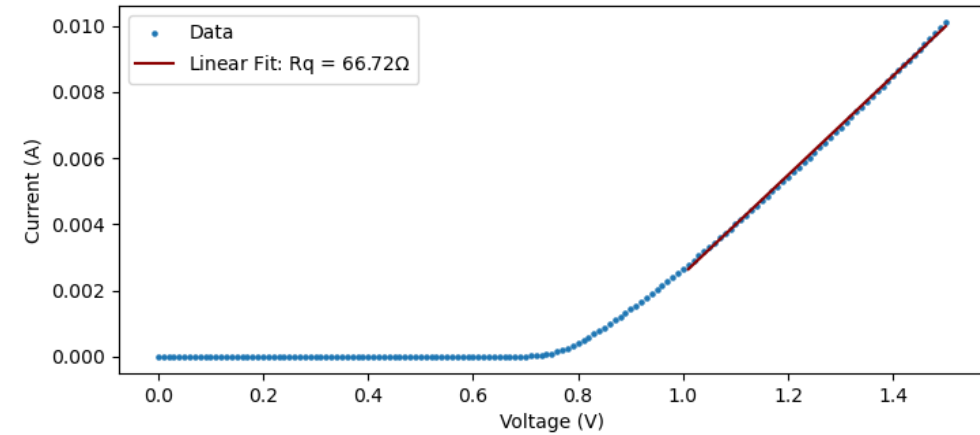
Time resolution



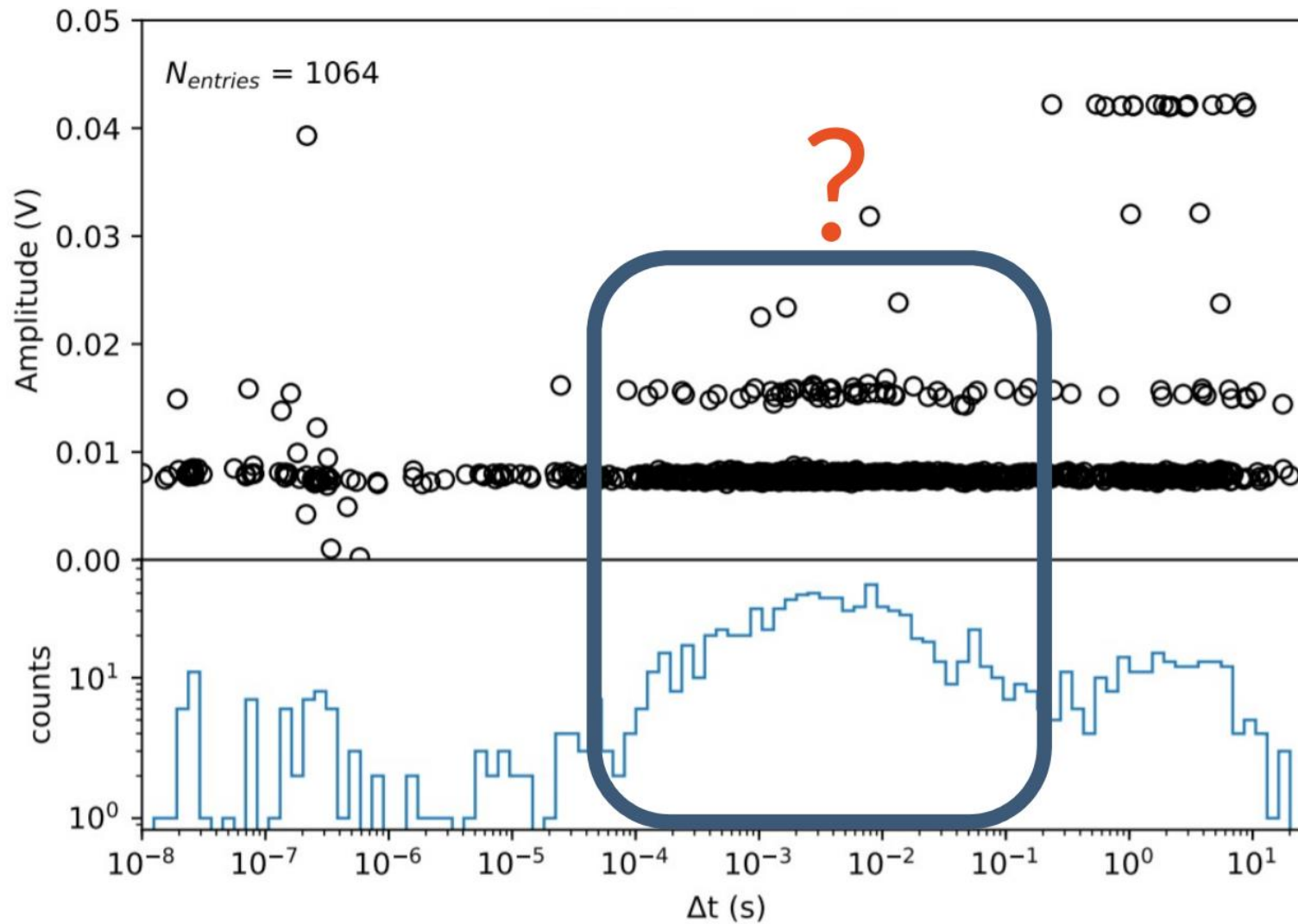
Setup (3)

Analysis through Python Scripts:

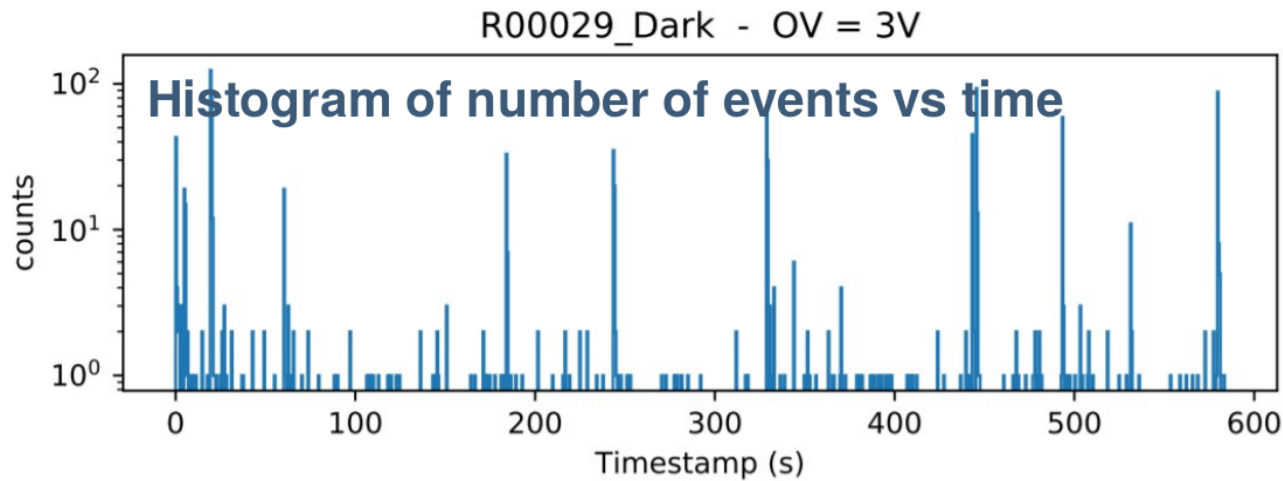
- Linear fit in direct IV;
- Polynomial fit in normalized derivative reverse IV;
- Peak amplitude in waveform
- Time study;
- Peak shape;
- Histograms;



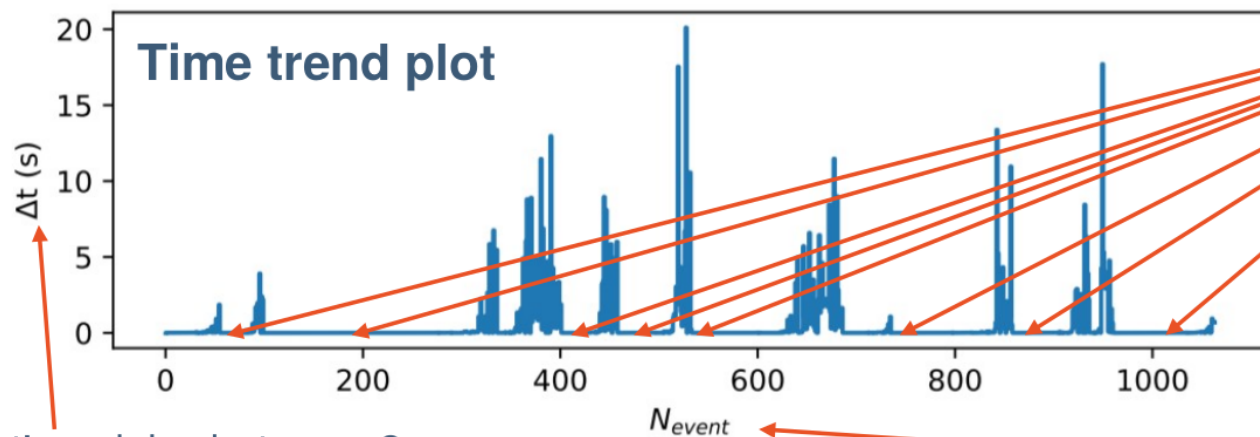
Signals in DCR: burst of events



Signals in DCR: burst of events



The broad peak in 2-dim plot centered at 0.01Hz is due to burst of consecutive events at frequencies in the range (100 Hz-1kHz)



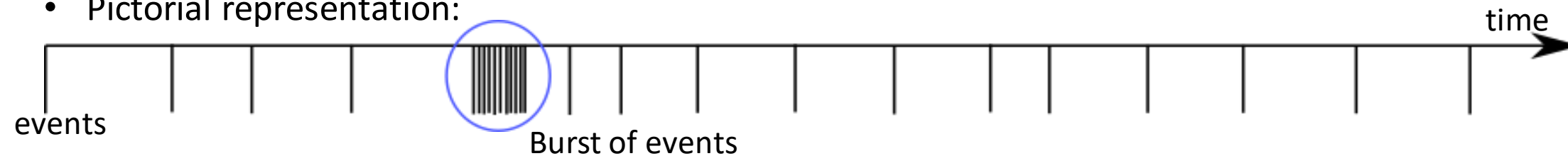
time delay between 2 consecutive events

event number

Signals in DCR: burst of events

The bursts:

- Consecutive random events with 1ms to 10ms time delay between each other
- Duration of one burst between 100ms-2s;
- A burst can contain from tens to hundred of single events (average ~ 50events);
- The mean amplitude of the events in the burst is 1p.e.;
- Observed from $T=-60^{\circ}$ in some samples;
- Different from model to model;
- Under further investigations
- Pictorial representation:

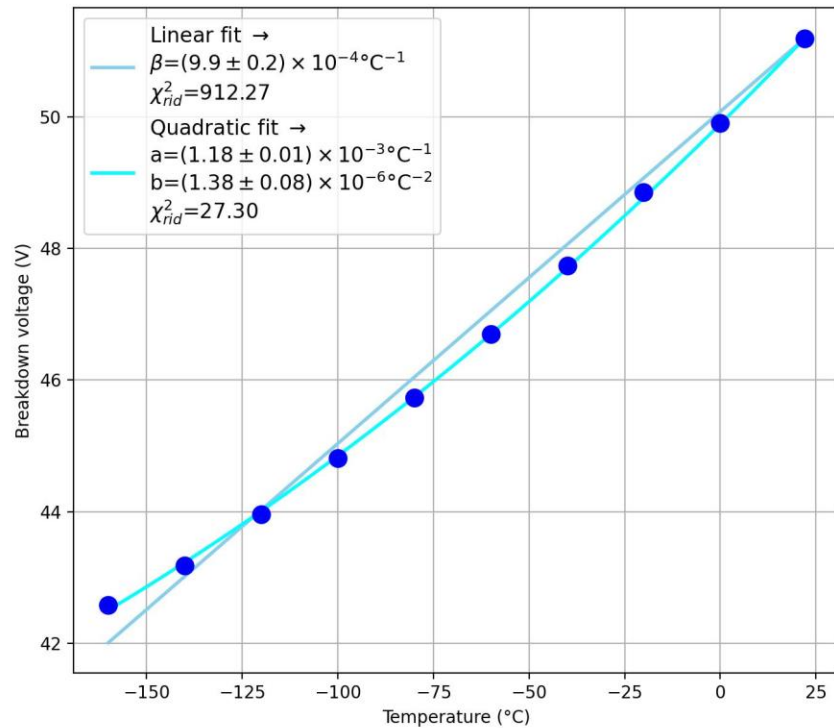


For more detail see:

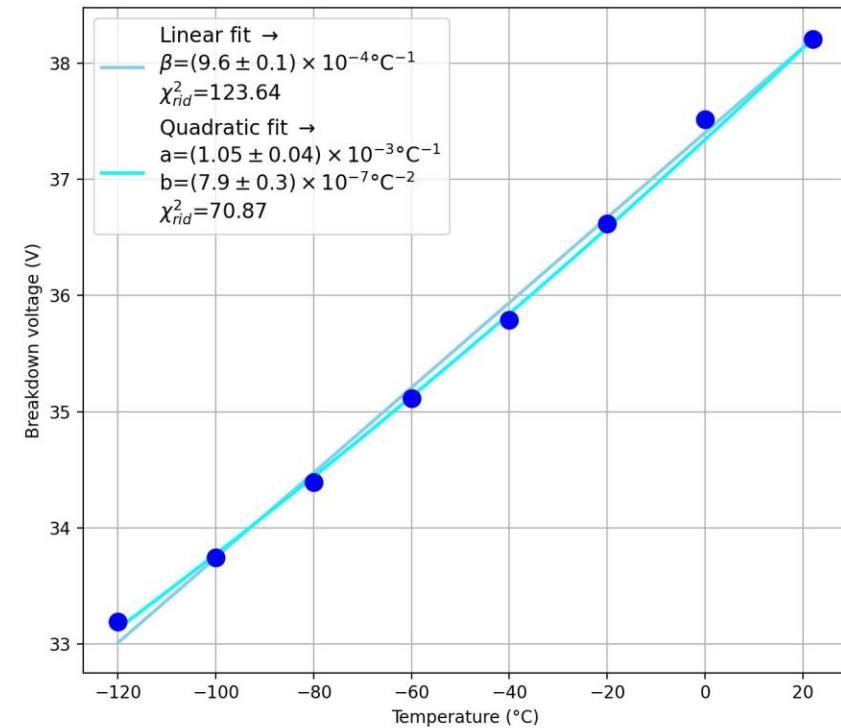
"A newly observed phenomenon in the characterisation of SiPM at cryogenic temperature" M. Guarise et al., Journal of instrumentation, vol16 (2021) DOI 10.1088/1748-0221/16/10/T10006

Results: breakdown voltage

Example of HPK S13360-3025CS



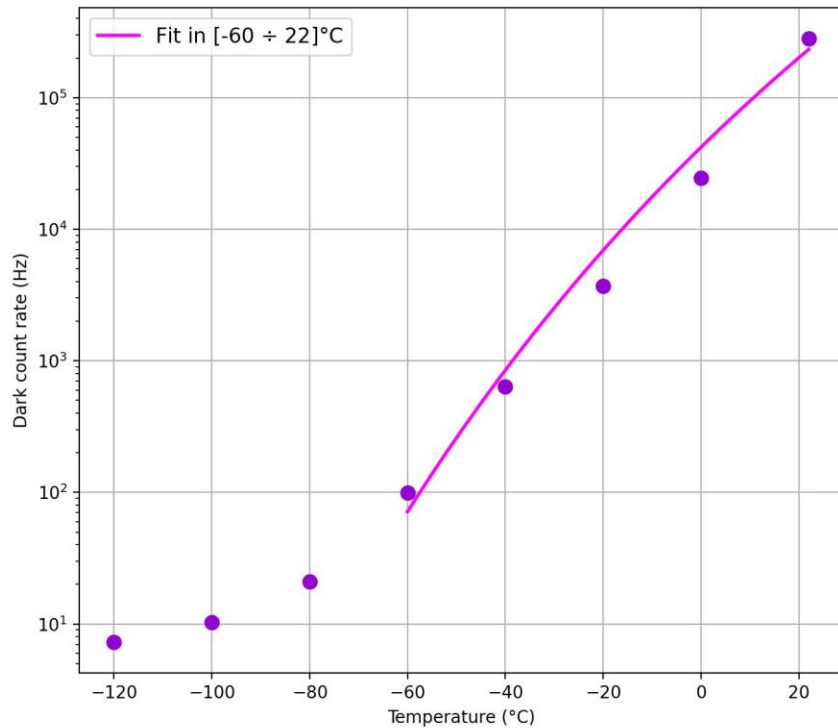
Example of HPK S14160-3015PS



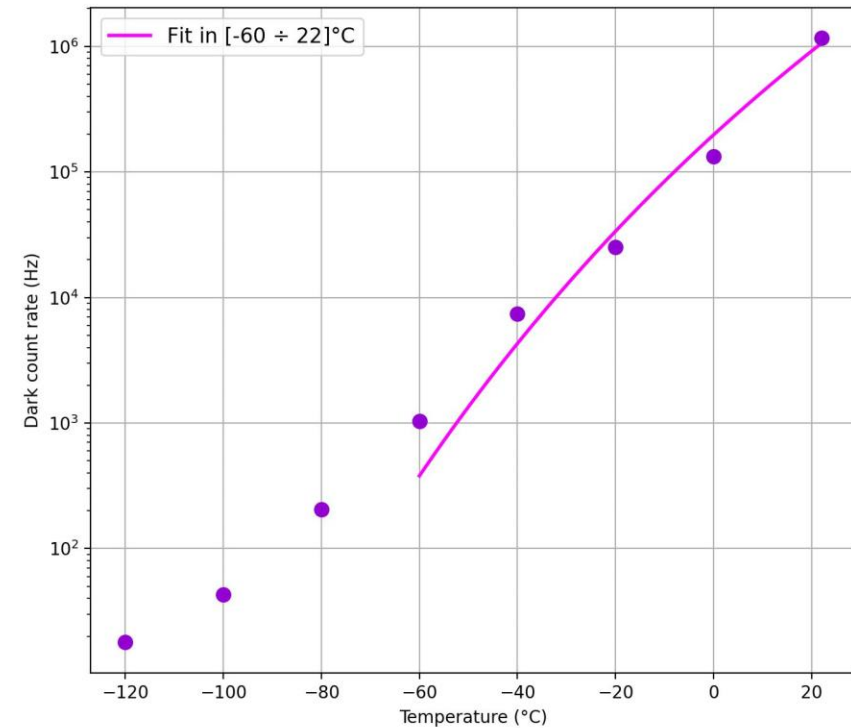
Empirical models: linear & quadratic

Results: DCR

Example of HPK S13360-3025CS



Example of HPK S14160-3015PS

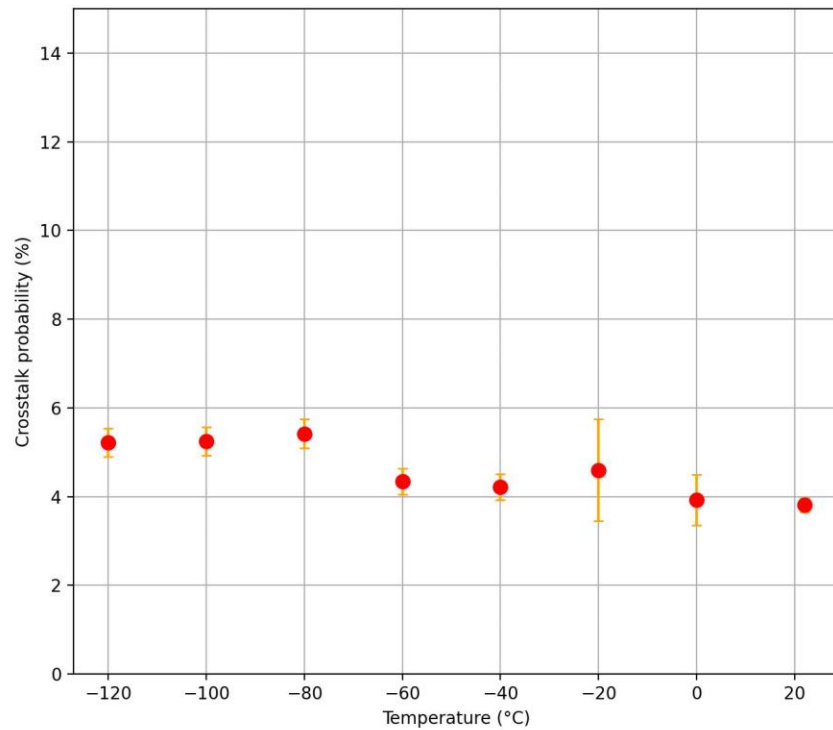


Empirical model: $DCR(T) = a \cdot T^2 \cdot \exp\left(-\frac{b}{k_B T}\right)$

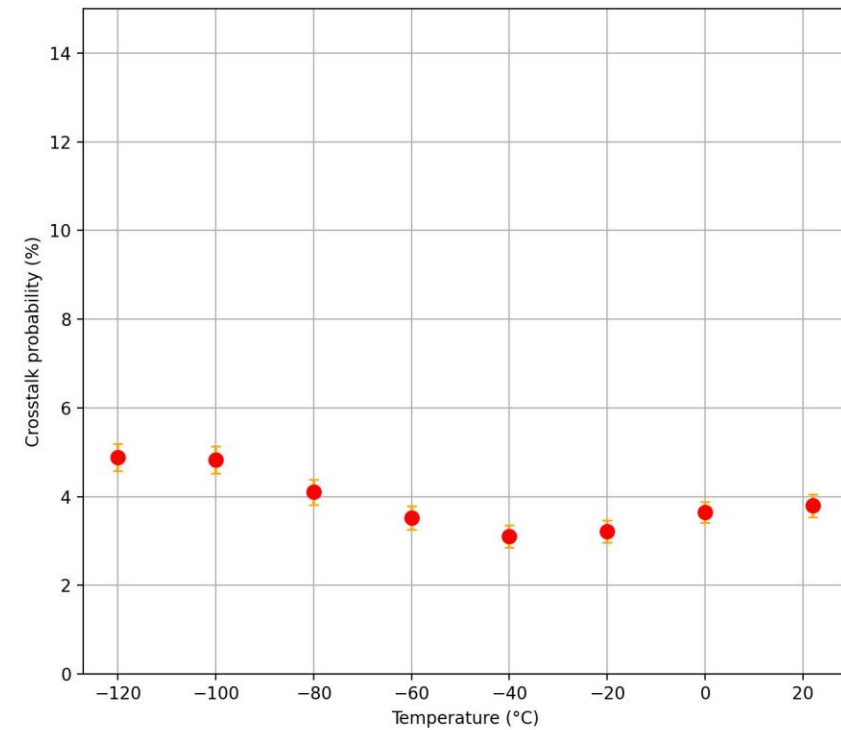
b: activation energy ~0.5eV

Results: CT

Example of HPK S13360-3025CS



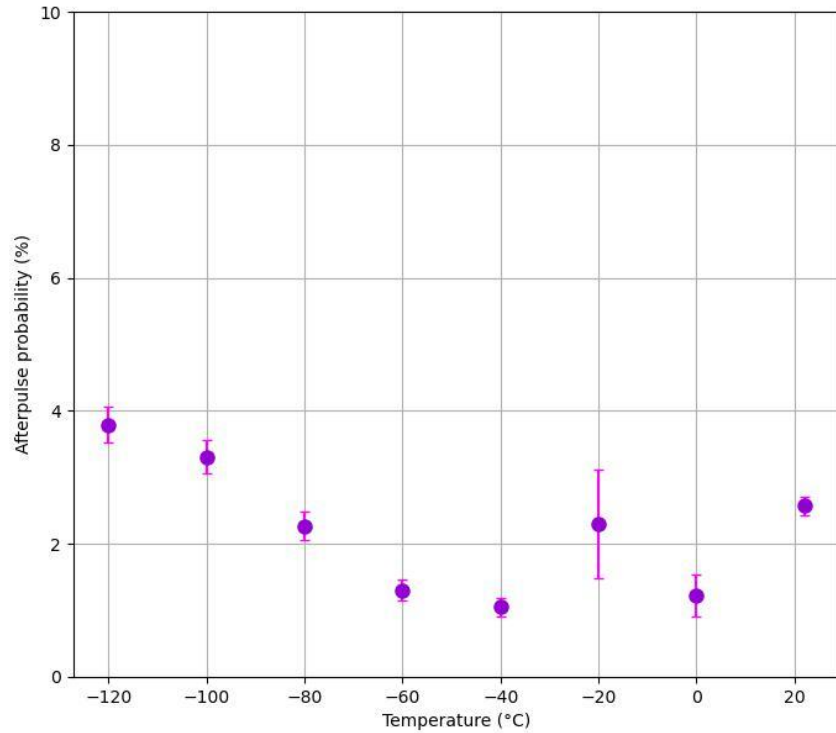
Example of HPK S14160-3015PS



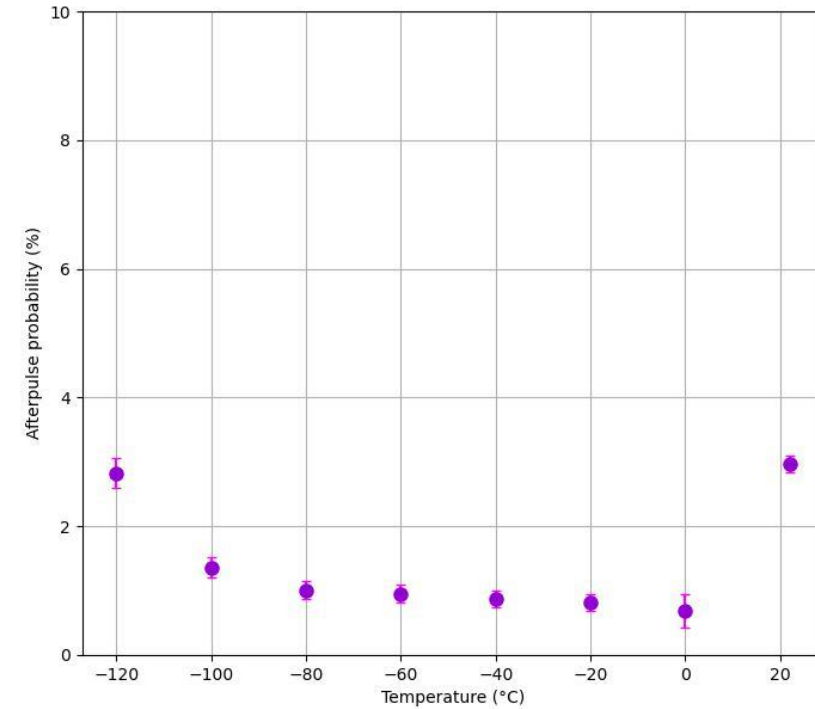
Roughly constant trend

Results: AP

Example of HPK S13360-3025CS



Example of HPK S14160-3015PS



Roughly constant trend

Resume of results before irradiation

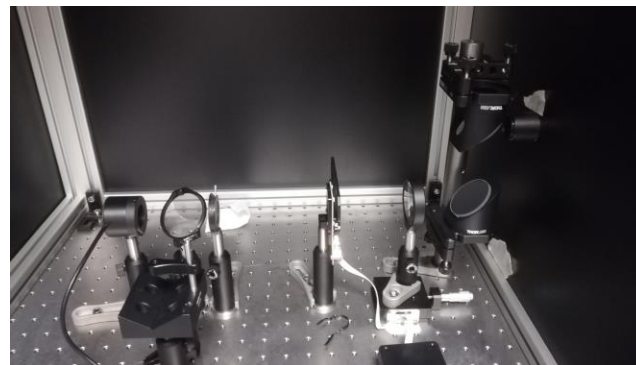
For almost all SiPM models we performed IV and DCR characterization in the range $[-120:25]^\circ$ in step of 20°

	S13360 -3025CS	S13360 -3025PE	S13360 -3050VE	S14160 -3015PS	S14160 -3050HS	S13081 -050CS
R_q range (Ω)	[51.3 ÷ 94.1]*	[50.9 ÷ 79.7]	[69.9 ÷ 81.1]	[20.0 ÷ 33.6]	[118.8 ÷ 245.5]	[367.0 ÷ 761.6]
R_q th. coef. (Ω/°C)	$[-2.2 \pm 0.1] \times 10^{-1}$	$[-2.02 \pm 0.09] \times 10^{-1}$	$[-7.9 \pm 0.5] \times 10^{-2}$	$[-9.0 \pm 0.6] \times 10^{-2}$	$[-7.8 \pm 0.7] \times 10^{-1}$	$[-2.5 \pm 0.2]$
V_{bd} range (V)	[42.59 ÷ 51.19]*	[43.87 ÷ 51.25]	[43.71 ÷ 51.33]	[33.29 ÷ 38.21]	[33.17 ÷ 39.19]	[44.90 ÷ 52.49]
V_{bd} th. coef. (V/°C)	$[5.04 \pm 0.08] \times 10^{-2}$	$[5.41 \pm 0.08] \times 10^{-2}$	$[5.6 \pm 0.1] \times 10^{-2}$	$[3.66 \pm 0.05] \times 10^{-2}$	$[3.64 \pm 0.04] \times 10^{-2}$	$[5.54 \pm 0.07] \times 10^{-2}$
1 p.e. (mV) at 22 °C	[10.5 ± 0.5]	[10.7 ± 0.5]	[20 ± 1]**	[5.8 ± 0.6]	[20 ± 1]**	[36.5 ± 0.6]
DCR range	[7.3 Hz ÷ 282 kHz]	[1.4 Hz ÷ 325 kHz]	[25 ÷ 466] kHz ***	[18 Hz ÷ 1.2 MHz]	[1.1 ÷ 1.4] MHz ***	[0.5 Hz ÷ 59 kHz]
E_{act} (eV)	[0.49 ± 0.03]	[0.50 ± 0.06]		[0.48 ± 0.02]		[0.46 ± 0.05]
Burst events	✓ at -80 °C	✓ at -120 °C		×		×
CT (%)	[3.8 ÷ 5.2]	[3.6 ÷ 6.8]	[10.8 ÷ 15]***	[3.1 ÷ 4.9]	[3.9 ÷ 27]***	[6.0 ÷ 9.4]
AP (%)	[1.0 ÷ 3.3]	[0.7 ÷ 3.0]	[3.7 ÷ 13.0]***	[1 ÷ 10]	[22 ÷ 49]***	[2 ÷ 11]

Perspectives

Plans for the (near) future:

- **Improve the setup:** new shielded box for SiPMs, new low noise amplifier, new power supply filter,...;
- **Complete the characterization of the models presented;**
- **New models procurement:** different area, cell pitch, technology,...
- **Irradiation campaign:** define place, dose, kind of sensors, number of sensor,...;
- **Instrument the setup for PDE measurements:** monochromator, calibrated photodiode, room T calibration;
- **Further test on burst behaviour:** HPK & FBK synergy, new models, further tests,...



N.B. DRD4 Framework

Conclusions

In Ferrara:

- We can perform **SiPM characterization down to LN2 temperature in LN2 vapour** through a dedicated custom multipurpose system (IV, DCR & correlated noise, time resolution);
- We tested so far 6 different HPK models (different pitch, different package, different fill factor, different chip, ...);

Some results:

- IV standard behaviour (also temperature dependence);
- DCR behaviour with **burst effect** (random train of pulses at kHz);
- DCR decreases from MHz at room temperature down to Hz at -120° ;
- DCR lower value: $150\text{mHz}/\text{mm}^2$ @ -120° for 13360-3025PE;

For the near future:

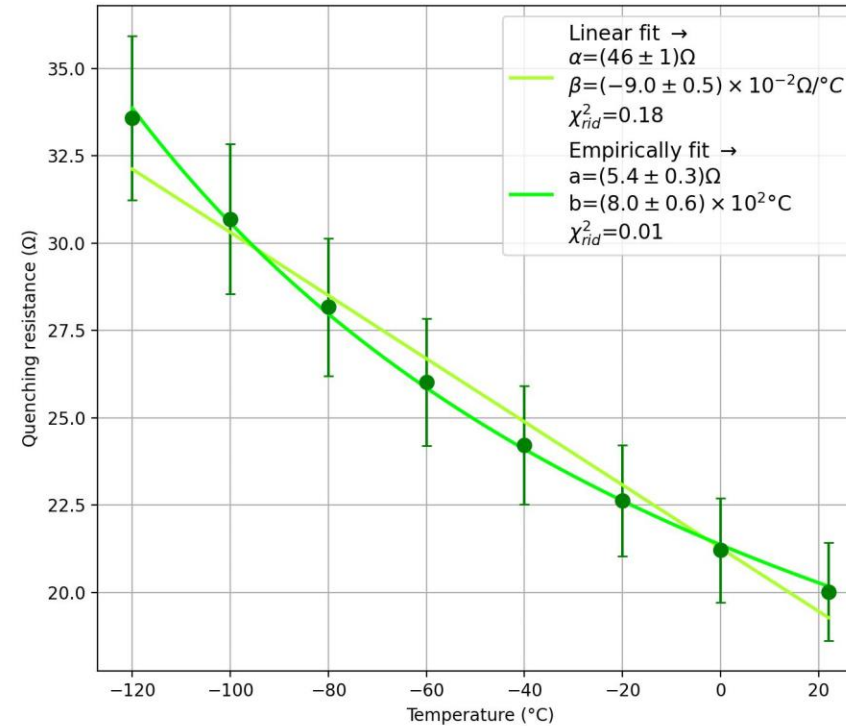
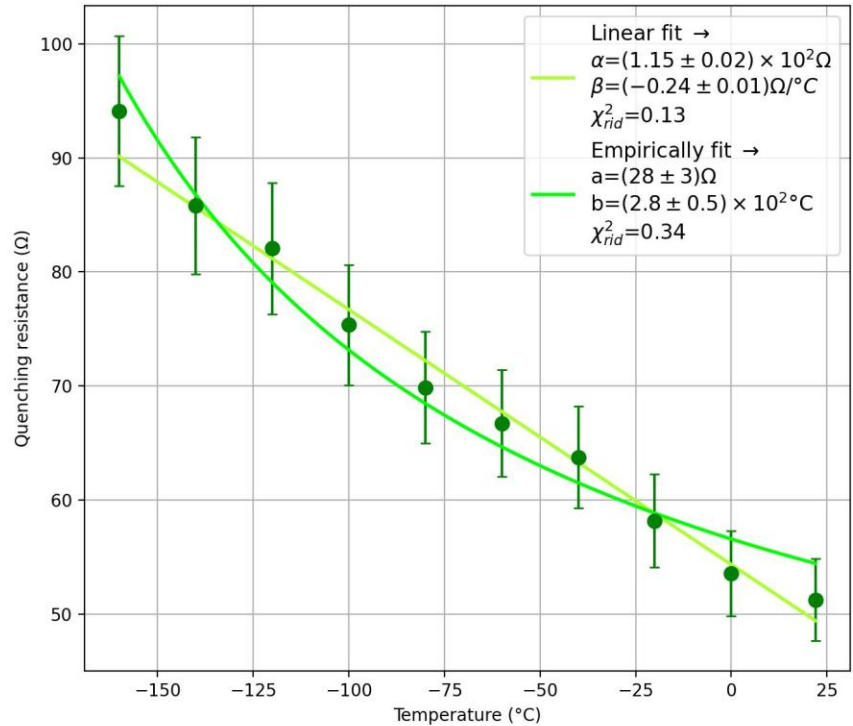
- Upgrade of setup (noise reduction);
- We plan to instrument PDE test setup;
- We plan to test these sensors after **different dose irradiation**;
- We plan to test the irradiated sensors after **different annealing procedure**;

The end

Thanks!



Back-up: quenching resistor



Back-up: time resolution

